

Search Notes

Application/Control No.

09/865,056

Examiner

David T. Fidei

Applicant(s)/Patent under
Reexamination

MATHIEZ, JEAN-LOUIS

Art Unit

3728

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|--------------------------|-----------|----------|
| 132 | 293 294 299 307 | 1/9/2006 | DTF |
| 206 | 581 | 1/9/2006 | DTF |
| Above | Updated | 9/14/2006 | DTF |
| 220 | 720 721 | 9/14/2006 | DTF |
| Above | Updated | 4/25/2007 | DTF |
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INTERFERENCE SEARCHED

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| PGPub text search - see interference printout | | 4/25/2007 | DTF |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| Consulted Examiner Hylton Class 220 | 9/14/2006 | DTF |
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